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Comparison of aluminum and sodium doped poly(vinylidene fluoride-trifluoroethylene) copolymers by x-ray photoemission spectroscopy

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The chemical interaction between the simple metals, aluminum and sodium, and crystalline copolymer thin films of vinylidene fluoride (70%) with trifluoroethylene (30%), has been studied using x-ray photoemission spectroscopy. Aluminum and sodium metalize the polymer differently and different binding sites for the two metals can be inferred from the corresponding core level shifts. Aluminum leads to enhanced screening of final photoemission states associated with the polymer, while sodium doping strongly influences the fluorine, but perturbs the carbon backbone only slightly. © 2001 American Institute of Physics. [DOI: 10.1063/1.1340858]

Aluminum and sodium are both simple metals dominated by a valence *sp* band. The aluminum atoms are believed to interact with the conjugated system to form covalent bonds and an aluminum overlayer is believed to form with Al evaporation with these polymers.^{1–3} Strong interactions were also observed in polyimides and polyesters,^{4,5} but the formation of an Al overlayer was, nonetheless, observed. For the copolymer vinylidene fluoride (70%) with trifluoroethylene (30%), there is compelling evidence that Al does not form a simple overlayer and diffusion into the polymer in the surface region does occur.⁶ The behavior of aluminum is in marked contrast to the evaporation of alkali metals on many organic polymers.^{1,3,7–9} The appearance of states in the highest occupied molecular orbital-lowest occupied molecular orbital gap has been reported for alkali doping of a number of molecular systems^{1,3,8–10} including the vinylidene fluoride (70%) with trifluoroethylene (30%) copolymer.¹¹ The alkali metals induced states generally act as Hubbard bands¹¹ in the otherwise empty band gap. There exists a large number of studies of aluminum and sodium doping of large organic molecular overlayers yet final state photoemission effects with changing metalization are rarely discussed in polymer systems.

Crystalline copolymer thin film of vinylidene fluoride (70%) with trifluoroethylene (30%), P(VDF–TrFE 70:30), is a material with recognized excellent dielectric and ferroelectric properties.¹² In this letter, we have compared the interaction between the low work function simple metals, aluminum and sodium, and P(VDF–TrFE 70:30) copolymer thin films.

The crystalline P(VDF–TrFE 70:30) films were formed

by Langmuir–Blodgett monolayer deposition from a water subphase^{12,13} and deposited on silicon for x-ray photoemission spectroscopy (XPS) studies described in detail elsewhere.¹⁴

In Fig. 1 we present a series of angle-resolved carbon 1s XPS spectra of 5 monolayer (ML) film of P(VDF–TrFE 70:30) from a clean sample [Fig. 1(a)] and from an aluminum doped sample [Fig. 1(b)] as well as Al 2*p* spectra from the aluminum-doped sample [Fig. 1(c)]. For the clean copolymer sample, the position of the higher binding energy (290.7 eV) C 1s XPS peak is independent of emission angle, while the C 1s peak of the lower binding energy shifts with increasing emission angles from 285.9 eV at 0° emission angle to less than 285.1 eV at 60° emission angle, as seen in Fig. 1(a). There is also a weak feature at 288.4 eV binding energy.

A correct assignment of chemical states to specific core level binding energies requires a clear distinction between initial and final states in photoemission (which is difficult in polymers) and was not undertaken in previous core level photoemission studies for poly[–CH₂–CF₂–]– and poly[–CHF–CF₂–]–.¹⁵ Conduction band spectroscopy^{11,16,17} provides strong evidence that the density of states near the Fermi level at the surface region is greater than that in the bulk at room temperature. We can reasonably anticipate greater improved core-hole screening (and final state photoemission binding energy shifts) at the surface than in the bulk. In angle-resolved XPS (ARXPS), increasing the emission angle increases the surface sensitivity. So the main feature of C 1s core level (located at 285.9 eV at 0° emission angle) shifts to lower binding energy as a result of improved surface screening effect. Attributing the C 1s peak located at 290.7 eV to an unscreened final state in this picture is supported by the suppression of this state with Al doping and the enhancement of this state with Na doping, as discussed later.

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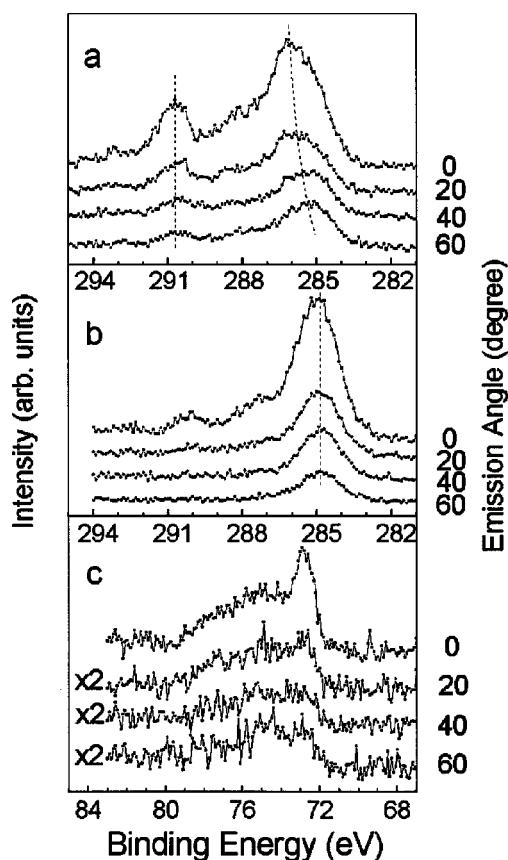


FIG. 1. Angle-resolved X-ray photoemission spectra for a 5 ML crystalline P(VDF-TrFE 70:30) copolymer thin film. (a) The C 1s core level from clean P(VDF-TrFE) as a function of emission angle. (b) The angle-resolved C 1s core level at several different emission angles following aluminum deposition and 6 h annealing at 393 K. (c) Al 2p core level immediately following deposition on P(VDF-TrFE) at room temperature.

In Fig. 2, C 1s, F 1s, and Na 1s core levels are shown for different sample conditions. All the spectra were taken at normal emission. The sodium, as deposited on the 5 ML film of P(VDF-TrFE 70:30) at 200 K, exhibits a Na 1s line shape with two distinct features characteristic of an inhomogeneous distribution of alkali metal, which also appears for aluminum doping. There is a clear plasmon like loss feature at 1077 eV binding energy characteristic of sodium clustering.^{11,18} Annealing the film to 350 K leads to a far more uniform distribution of alkali metal without any evidence of metallic cluster formation, as seen from Fig. 2. The C 1s and F 1s core levels all change dramatically after sodium doping, as in the aluminum doping case, but with some differences. The lower binding energy C 1s peak at 285.9 ± 0.1 eV and F 1s peak at 688.2 ± 0.2 eV both shift to the lower binding energies: 285.3 ± 0.1 eV and 686.2 ± 0.2 eV, respectively. The C 1s core level feature at 290.7 ± 0.5 eV shifts to higher binding energy: 291.1 ± 0.2 eV with sodium doping. This carbon core level (at 290.7 eV binding energy) therefore cannot be associated with the C-F₂ bonds, and the literature assignment, based on initial state chemical configurations,¹⁵ is questionable. Final state effects, like screening, are implicated in the changes in intensity and core level binding energy shift of this carbon core feature.

The core level spectra following deposition of a nominal 5-Å-thick aluminum overlayer (as determined from the thin film thickness monitor) on 5 ML thick copolymer P(VDF-

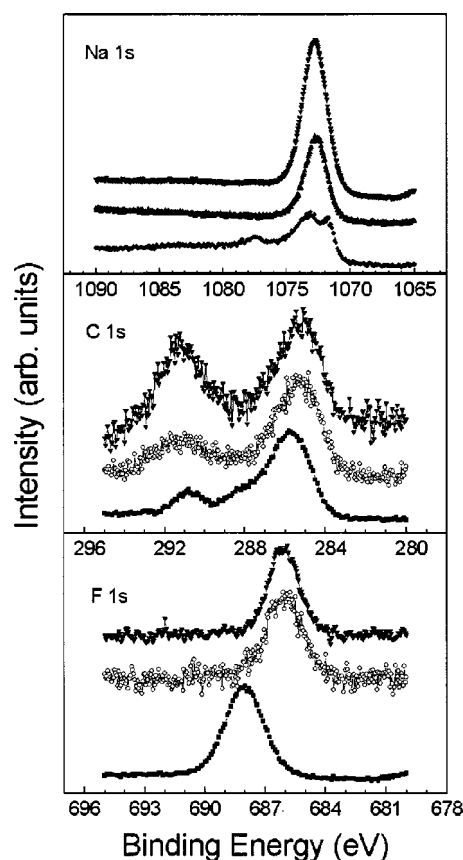


FIG. 2. Na 1s, C 1s, and F 1s x-ray photoemission spectra of the 5 ML crystalline P(VDF-TrFE) copolymer thin film. Spectra for Na 1s are from 1 ML Na freshly deposited and unannealed (●) and then annealing to 423 K (▲), also from 4 ML Na (equivalent) doped and annealed sample (▼). Spectra for C and F are from clean copolymer sample (■), 2ML Na doped and annealed sample (○) and 4 ML Na doped and annealed sample (▼).

TrFE 70:30) film at room temperature is shown in Fig. 3. The aluminum XPS core level spectrum from a fresh aluminum deposition exhibits an Al 2p line shape with two distinct features: a sharp peak located at 72.8 eV again suggesting the formation of metallic clusters^{6,19} and a broad peak at a higher binding energy (~ 76 eV), as seen in Fig. 3. The distribution of aluminum in the copolymer thin film was investigated by ARXPS⁶ and shown to be quite uniform in 5 ML P(VDF-TrFE 70:30) copolymer thin films.

The XPS C 1s and F 1s core level line shapes and binding energies of the copolymer film change following deposition of aluminum, but change little further when the sample is annealed at 393 K after aluminum deposition. As shown in Fig. 3, all peaks for C 1s and F 1s shift to lower binding energy after aluminum doping. The decrease in binding energy for all the C 1s as well as the F 1s core levels is similar: about 0.5–1 eV. Another important change is the ratio of the intensity of C 1s peak located at 290.7 eV binding energy to that located at 285.9 eV binding energy. The C 1s core level, attributable to an unscreened final state at 290.7 eV in the undoped material, is strongly suppressed altogether with Al doping.

With sodium doping, the F 1s core level shifts about 2 eV while the lower binding energy C 1s peak (285.9 eV) shifts about 0.6 eV. For aluminum doping, F 1s shifts about 0.4 eV while the lower binding energy C 1s peak (285.9 eV) shifts about 0.9 eV. Furthermore, the ratio of the intensity of

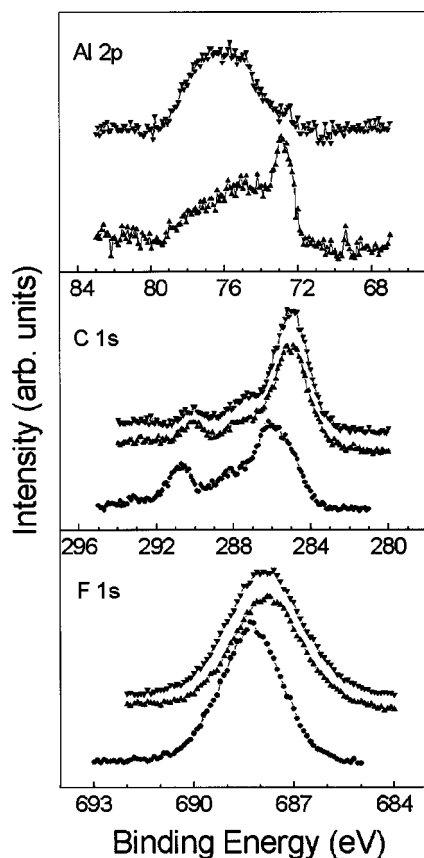


FIG. 3. Al 2*p*, C 1*s*, and F 1*s* x-ray photoemission spectra of the 5ML crystalline P(VDF-TrFE) copolymer thin film. The data from clean P(VDF-TrFE) copolymer film (●), aluminum deposited film without annealing (▲) and aluminum deposited film followed with 6 h annealing at 393 K (▼) are shown in the appropriate panels. The emission is normal to the surface.

the C 1*s* peak located at higher binding energy (290.7 eV) to that located at lower binding energy (285.9 eV) increases with increasing sodium doping but decreases with aluminum doping. The aluminum doping appears to lead to a copolymer film that has been metallized to the point where all the C 1*s* and F 1*s* core level binding energies are reduced. This provides further support to our contention that screening is a dominant effect on the binding energy. If the aluminum bonded strongly with one specific location along the polymer backbone, then the core levels would not shift to lower binding energies so uniformly. It is Na doping that leads to a more specific site interaction with P(VDF-TrFE 70:30) copolymer thin films so that a uniform screening of polymer backbone atoms does not occur.

Previous work with sodium doping in P(VDF-TrFE 70:30) copolymer thin films indicates that the strong sodium interaction with fluorine, detailed here, does not lead to C-F bond cleavage or the formation of a NaF salt. The valence band photoemission features of the P(VDF-TrFE 70:30) copolymer, due to the molecular orbitals, are seen to change dramatically with substantial chemical modification of the P(VDF-TrFE 70:30) copolymer sample.²⁰ In comparison, Na doping of P(VDF-TrFE 70:30) copolymer thin films al-

ters the photoemission molecular orbital features only very slightly: the most significant changes are the introduction of two lower Hubbard-like bands.¹¹ These valence band changes, in photoemission, are not characteristic of a molecular functional group change. In addition, the binding energies of F 1*s* and Na 1*s*, in our experiment, are quite different from literature values for NaF.²¹

From these differences between Na and Al doping on the core level binding energies, we can conclude that, although in both cases the metal atoms go into the copolymer film fairly uniformly after a slight amount of annealing (no clustering or preference for surface versus bulk sites), the two metals have different interactions with the copolymer backbones and probably occupy different bonding sites. Sodium atoms strongly interaction with fluorine atoms and donate electron(s) or fractional charge most directly to the fluorine atoms. The electrons on copolymer carbon backbone become more localized with sodium doping, and this is indicated by the increasing intensity of unscreened C 1*s* final state at 290.7 eV that shifts to higher binding energy: 291.1 eV. The localization of charge with sodium doping, rather than increasing apparent metallization, helps accounting for the large correlation energy suggested by the presence of Hubbard bands apparent with sodium doping of P(VDF-TrFE 70:30) copolymer thin films reported previously.¹¹ For aluminum doping, the metal atoms prefer to interact with delocalized influence along the copolymer backbones, and this leads to a better core-hole screening, for both fluorine and carbon atoms, in addition to suppressing the unscreened C 1*s* state.

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- ¹P. Dannelun *et al.*, *J. Chem. Phys.* **100**, 6765 (1994).
- ²P. Dannelun *et al.*, *J. Chem. Phys.* **99**, 664 (1993).
- ³M. Fahlman *et al.*, *Synth. Met.* **78**, 237 (1996).
- ⁴P. S. Ho *et al.*, *J. Vac. Sci. Technol. A* **3**, 739 (1985).
- ⁵M. Bou, J. M. Martin, T. Le Mogne, and L. Vovelle, in *Metallized Plastics* 2, edited by K. L. Mittal (Plenum, New York, 1991), p. 219.
- ⁶B. Xu *et al.*, *J. Chem. Phys.* **114** (2001) (in press).
- ⁷M. Lögdlund *et al.*, *Phys. Rev. Lett.* **63**, 1841 (1989).
- ⁸M. Fahlman *et al.*, *Chem. Phys. Lett.* **214**, 327 (1993).
- ⁹M. Lögdlund *et al.*, *Phys. Rev. Lett.* **70**, 970 (1993).
- ¹⁰T. Miyamae *et al.*, *J. Electron Spectrosc. Relat. Phenom.* **78**, 399 (1996).
- ¹¹J. Choi *et al.*, *Phys. Rev. B* **59**, 1819 (1999).
- ¹²L. M. Blinov *et al.*, *Usp. Fiz. Nauk* **43**, 243 (2000); A. V. Bune *et al.*, *Nature (London)* **391**, 874 (1998).
- ¹³S. Palto *et al.*, *Ferroelectr. Lett. Sect.* **19**, 65 (1995); L. M. Blinov, *Sov. Phys. Usp.* **31**, 623 (1988).
- ¹⁴D. N. McIlroy *et al.*, *Phys. Rev. B* **54**, 17438 (1996).
- ¹⁵D. T. Clark *et al.*, *J. Polym. Sci., Polym. Chem. Ed.* **11**, 389 (1973).
- ¹⁶J. Choi *et al.*, *Phys. Lett. A* **249**, 505 (1998).
- ¹⁷J. Choi *et al.*, *Phys. Rev. B* **61**, 5760 (2000).
- ¹⁸T. Reiners *et al.*, *Phys. Rev. Lett.* **74**, 1558 (1995).
- ¹⁹G. E. McGuire *et al.*, *Inorg. Chem.* **12**, 2451 (1973).
- ²⁰Jaewu Choi *et al.*, *Appl. Phys. Lett.* **76**, 381 (2000).
- ²¹W. E. Morgan, J. R. Van Wazer, and W. J. Stec, *J. Am. Chem. Soc.* **95**, 751 (1973).